



DOI: [10.5958/2249-7137.2021.01864.4](https://doi.org/10.5958/2249-7137.2021.01864.4)

## EFFECTIVE METHOD FOR PHOTOGRAPHIC RECORDING OF HEAT FIELDS OF OBJECTS AND LASER RADIATIONS BASED ON A GAS DISCHARGE CELL

**Sharifa Bekmuradovna Utamuradova\***; **Khojakbar Sultanovich Daliev\*\***;  
**Zokir Khaydarov\*\*\***; **Dilmurod Abdujabbor ugli Rakhmanov\*\*\*\***

\*Doctor of Physical and Mathematical Sciences,  
Director of Research Institute of semiconductor physics and microelectronics,  
UZBEKISTAN

Email id: sh-utamuradova@yandex.ru

\*\*Doctor of Physical and Mathematical Sciences,  
Executive Director of the National Research University,  
"Moscow Power Engineering Institute" in Tashkent,  
UZBEKISTAN

\*\*\*Candidate of Physical and Mathematical Sciences,  
Research Institute of semiconductor physics and microelectronics,  
UZBEKISTAN

\*\*\*\*PhD Student,  
Research Institute of Semiconductor Physics and Microelectronics,  
UZBEKISTAN

Email id: dilmurod-1991@bk.ru

### ABSTRACT

*This paper describes the design of a semiconductor photographic ionization camera used for spatio-temporal diagnostics of thermal fields of objects in the infrared wavelength range up to 30  $\mu\text{m}$  and beyond. The results of experimental studies of photo detectors made of silicon doped with platinum and sulfur in a semiconductor photographic ionization camera gas-discharge cell are presented. It is shown that high sensitivity of the photographic process is provided due to a new photographic effect, which is associated with the phenomenon of photoelectric hysteresis.*

**KEYWORDS:** *Diagnostics, Thermal Field, Laser Radiation, Photographic Effect, Photoelectric Hysteresis.*

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